

Description

The SI7328DN-T1-GE3 use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness.

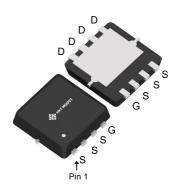
General Features

V_{DS} =30V I_D = 40A

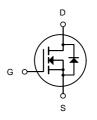
 $R_{DS(ON)} < 6.3 \text{m}\Omega$ @ $V_{GS}=10V$

Applications

Consumer electronic power supply Motor control Synchronous-rectification Isolated DC Synchronous-rectification applications



DFN3X3-8L



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SI7328DN-T1-GE3	DFN3X3-8L	HXY MOSFET	5000

Absolute Maximum Ratings (Tc=25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	40	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	28	А
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	27	А
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	24	А
Ідм	Pulsed Drain Current ²	135	А
EAS	Single Pulse Avalanche Energy ³	29.8	mJ
las	Avalanche Current	27	А
P _D @T _C =25°C	Total Power Dissipation ⁴	30	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-ambient ¹	50	°C/W
Reлc	Thermal Resistance Junction-Case ¹	4.6	°C/W



Electrical Characteristics(TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV_DSS	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =250 u A	30			V
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =20A		5	6.3	mΩ
		V _{GS} =4.5V , I _D =15A		6.9	9	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2		2.5	V
	D : 0	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =20A		67		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (4.5V)			8		
Q _{gs}	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		2.4		nC
Q _{gd}	Gate-Drain Charge			3.2		
T _{d(on)}	Turn-On Delay Time			7.1		
Tr	Rise Time	V_{DD} =15V , V_{GS} =10V , R_{G} =3.3 Ω		40		ns
T _{d(off)}	Turn-Off Delay Time	I _D =15A		15		
T _f	Fall Time			6		
C _{iss}	Input Capacitance			814		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		498		pF
Crss	Reverse Transfer Capacitance			41		
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			40	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time	IF=20A , di/dt=100A/μs ,		15		nS
Qrr	Reverse Recovery Charge	T _J =25°C		25		nC

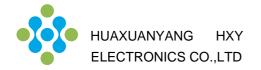
^{1.}The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =24A

^{4.}The power dissipation is limited by 150°C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

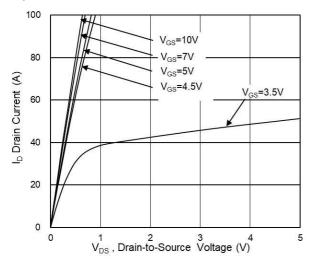


Fig.1 Typical Output Characteristics

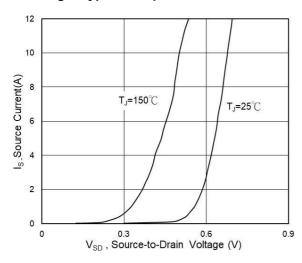


Fig.3 Source Drain Forward Characteristics

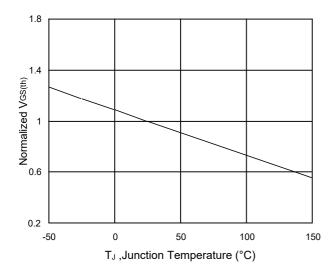


Fig.5 Normalized $V_{GS(th)}$ vs T_J

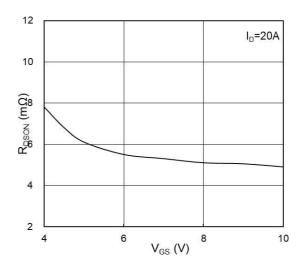


Fig.2 On-Resistance vs G-S Voltage

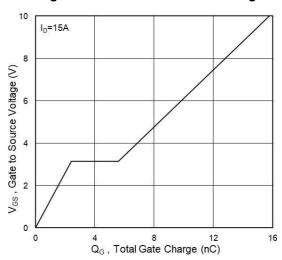


Fig.4 Gate-Charge Characteristics

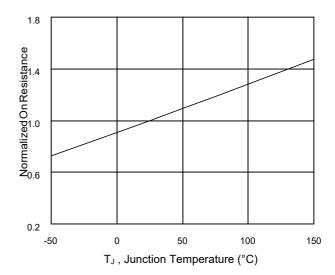
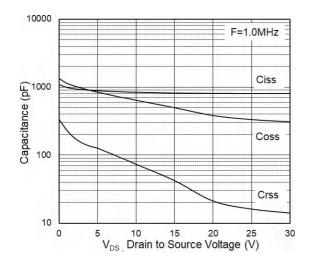


Fig.6 Normalized R_{DSON} vs T_J



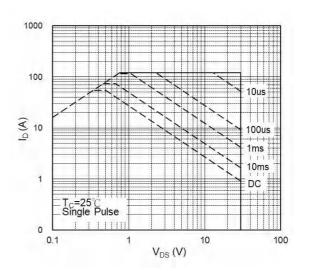


Fig.7 Capacitance

Fig.8 Safe Operating Area

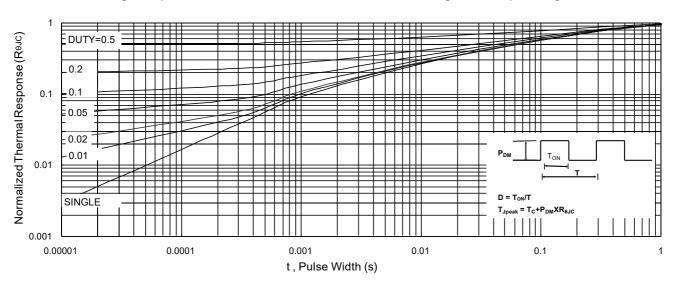


Fig.9 Normalized Maximum Transient Thermal Impedance

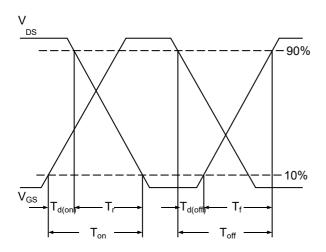


Fig.10 Switching Time Waveform

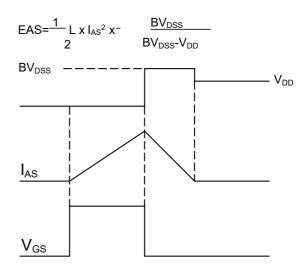
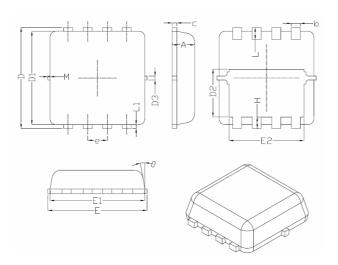


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters			
	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
M	*	*	0.15	
θ		10°	12 [°]	



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